


<b>Search Notes</b>  	<b>Application/Control No.</b>  10534500	<b>Applicant(s)/Patent Under Reexamination</b>  OHASHI ET AL.
	<b>Examiner</b>  Katarzyna Wyrozebski	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
524	445, 474, 495		
525	333.1, 333.3		
Updated		10/28/2008	KIW
UPDATED		2/4/2009	KIW

SEARCH NOTES			
Search Notes		Date	Examiner
east notes attached			
Inventor search			
ODP analysis		1/30/08	kiw
Updated		10/28/2008	KIW
UPDATED		2/4/2009	KIW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Katarzyna Wyrozebski/ Primary Examiner.Art Unit 1796
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